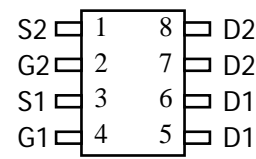
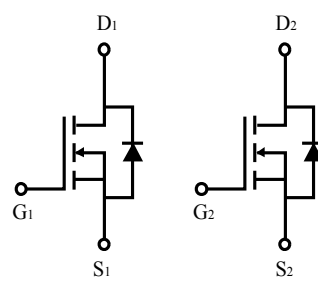
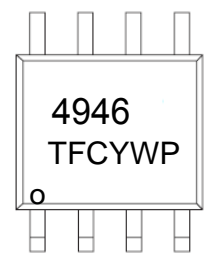


N-Channel Enhancement Mode Power MOSFET

<p>Description</p> <p>The 4946 uses advanced trench technology to provide excellent $R_{DS(on)}$ and low gate charge . The complementary MOSFETs may be used to form a level shifted high side switch, and for a host of other applications.</p> <p>General Features</p> <table border="1" style="width:100%; border-collapse: collapse; margin: 10px 0;"> <thead> <tr> <th colspan="3">PRODUCT SUMMARY</th> </tr> <tr> <th>V_{DSS}</th> <th>I_D</th> <th>$R_{DS(on)}$ (mΩ) Max</th> </tr> </thead> <tbody> <tr> <td rowspan="2" style="text-align: center;">60V</td> <td style="text-align: center;">5.3A</td> <td style="text-align: center;">42 @ $V_{GS} = 10V$</td> </tr> <tr> <td style="text-align: center;">4.7A</td> <td style="text-align: center;">52 @ $V_{GS} = 4.5V$</td> </tr> </tbody> </table> <ul style="list-style-type: none"> ● High power and current handing capability ● Lead free product is acquired ● Surface mount package 	PRODUCT SUMMARY			V_{DSS}	I_D	$R_{DS(on)}$ (m Ω) Max	60V	5.3A	42 @ $V_{GS} = 10V$	4.7A	52 @ $V_{GS} = 4.5V$	<p>SOP-8</p>  <p>Equivalent Circuit</p>  <p>MARKING</p>  <p>Y :year code W :week code</p>
PRODUCT SUMMARY												
V_{DSS}	I_D	$R_{DS(on)}$ (m Ω) Max										
60V	5.3A	42 @ $V_{GS} = 10V$										
	4.7A	52 @ $V_{GS} = 4.5V$										

Absolute Maximum Ratings $T_A=25^{\circ}C$ unless otherwise noted			
Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ^A	$T_A=25^{\circ}C$	I_D	A
Pulsed Drain Current ^B			
Power Dissipation ^A	$T_A=25^{\circ}C$	P_D	W
	$T_A=70^{\circ}C$	2	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	$^{\circ}C$

Thermal Characteristics				
Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$R_{\theta JA}$	48	62.5	$^{\circ}C/W$
Maximum Junction-to-Ambient ^A				
Maximum Junction-to-Lead ^C	$R_{\theta JL}$	35	40	$^{\circ}C/W$



SOP-8 Plastic-Encapsulate MOSFETS

4946

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D = 250μA, V _{GS} =0V	60			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 60V, V _{GS} =0V			100	nA
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} I _D = 250μA	1.0	1.5	2.0	V
I _{D(ON)}	On state drain current	V _{GS} = 4.5V, V _{DS} = 5V	20			A
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 5.3A		38	42	mΩ
		V _{GS} = 4.5V, I _D = 4.7A		43	52	mΩ
g _{FS}	Forward Transconductance	V _{DS} = 15V, I _D = 5.3A		12		S
V _{SD}	Diode Forward Voltage	I _S = 3A, V _{GS} =0V		0.8	1.2	V
I _S	Maximum Body-Diode Continuous Current				3	A

DYNAMIC PARAMETERS

C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =30V, f=1MHz		931		pF
C _{oss}	Output Capacitance			60		pF
C _{rss}	Reverse Transfer Capacitance			50		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			9.5	Ω

SWITCHING PARAMETERS

Q _g (10V)	Total Gate Charge (10V)	V _{DD} = 30V, V _{GEN} = 10V, I _D = 3A		20.2		nC
Q _g (4.5V)	Total Gate Charge (4.5V)			10.2		nC
Q _{gs}	Gate Source Charge			4.2		nC
Q _{gd}	Gate Drain Charge			3.5		nC
t _{D(on)}	Turn-On DelayTime	V _{DD} = 30V, V _{GEN} = 10V, R _L =10Ω R _{GEN} =6Ω		9.4		ns
t _r	Turn-On Rise Time			4.8		ns
t _{D(off)}	Turn-Off DelayTime			33.8		ns
t _f	Turn-Off Fall Time			5.6		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F = 5A, di/dt=100A/μs		23.5		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F = 5A, di/dt=100A/μs		13.4		nC

A: The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t_s ≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The R_{θJA} is the sum of the thermal impedance from junction to lead R_{θJL} and lead to ambient.

D: The static characteristics in Figures 1 to 6,12,14 are obtained using 80μs pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

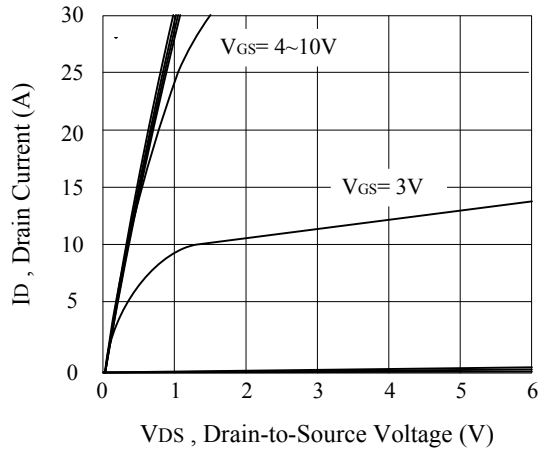


Figure 1. Output Characteristics

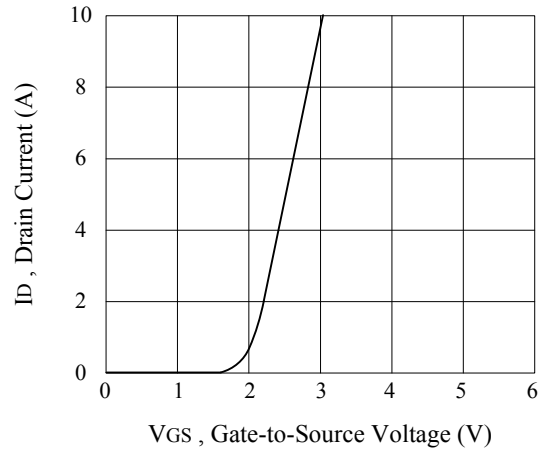


Figure 2. Transfer Characteristics

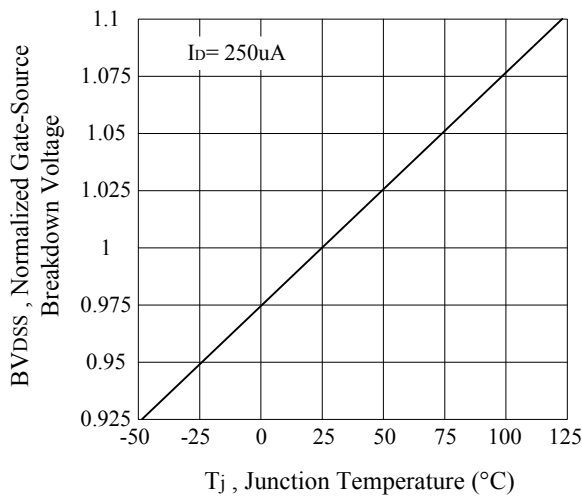


Figure 3. Breakdown Voltage Variation with Temperature

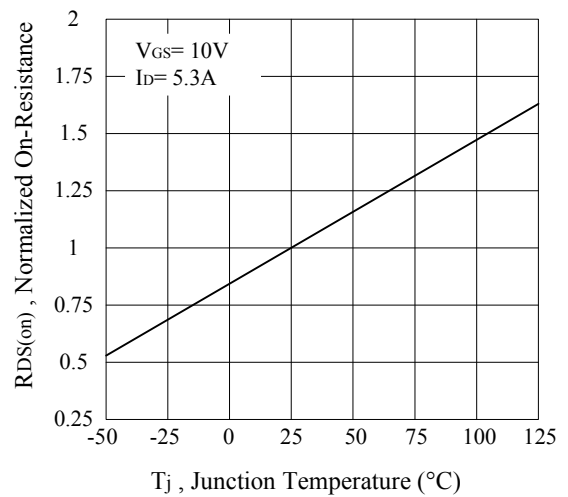


Figure 4. On-Resistance Variation with Temperature

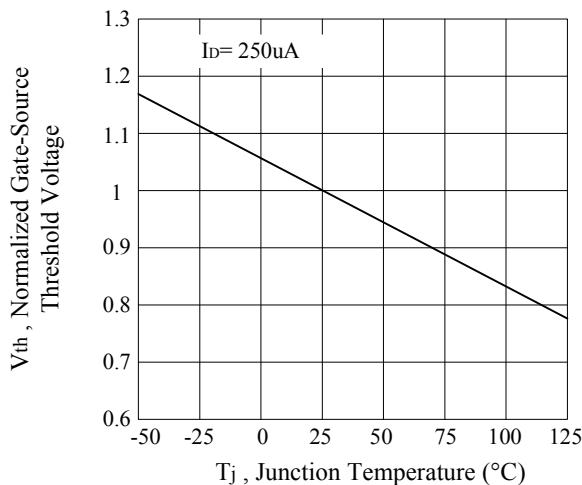


Figure 5. Gate Threshold Variation with Temperature

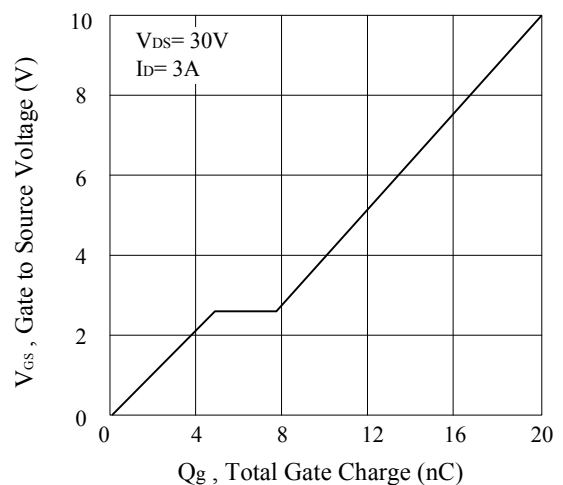
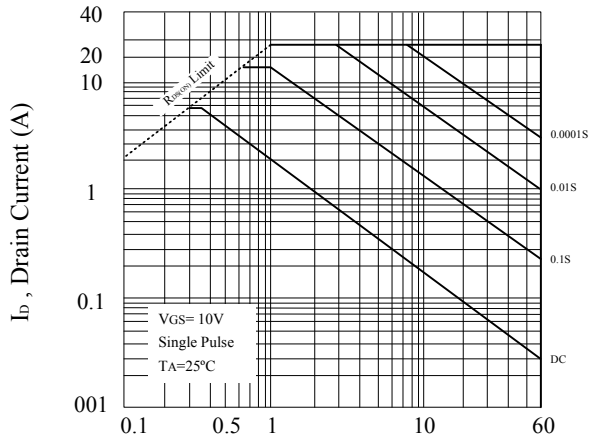
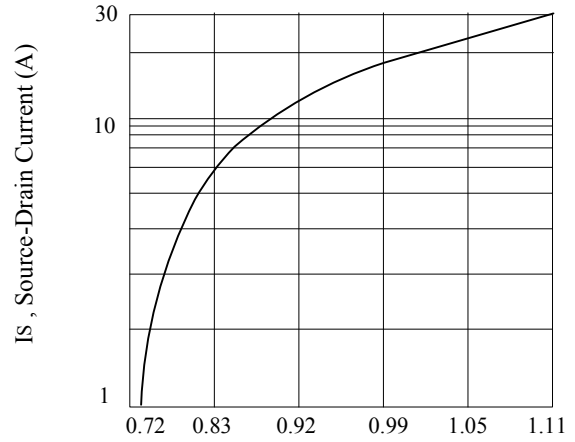


Figure 6. Gate Charge

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



VDS, Drain-Source Voltage (V)
Figure 7. Maximum Safe Operating Area



VSD, Body Diode Forward Voltage (V)
Figure 8. Body Diode Forward Voltage Variation with Source Current

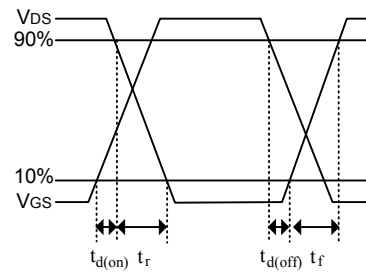
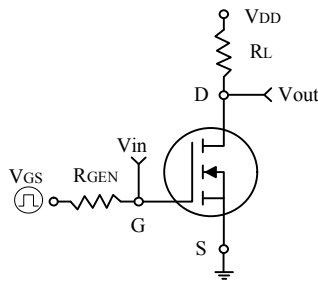


Figure 9. Switching Test Circuit and Switching Waveforms

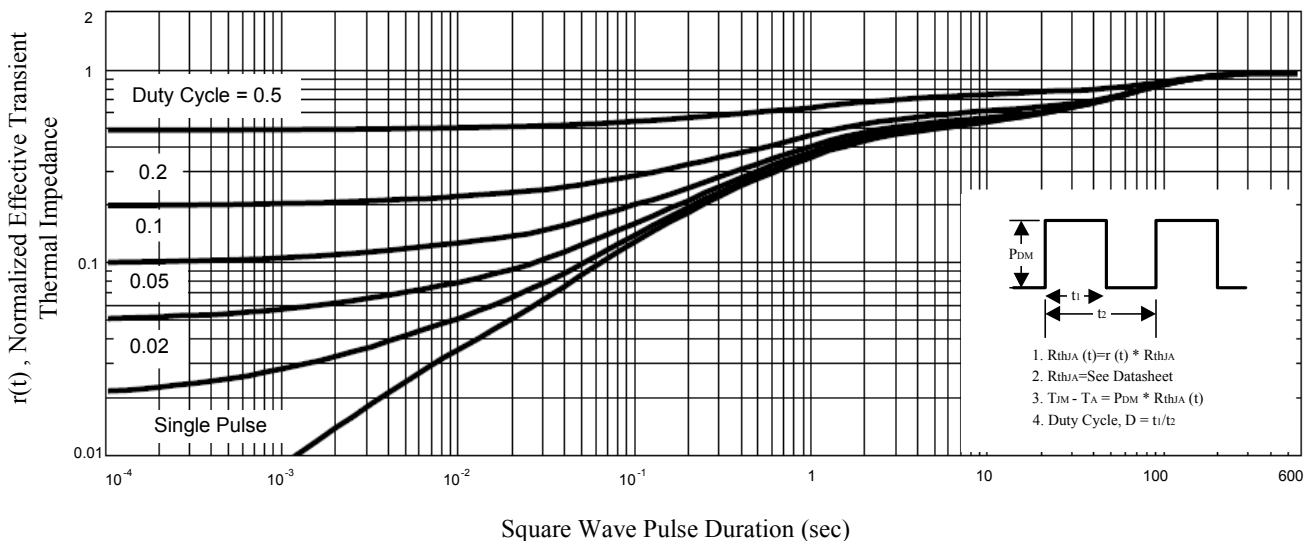
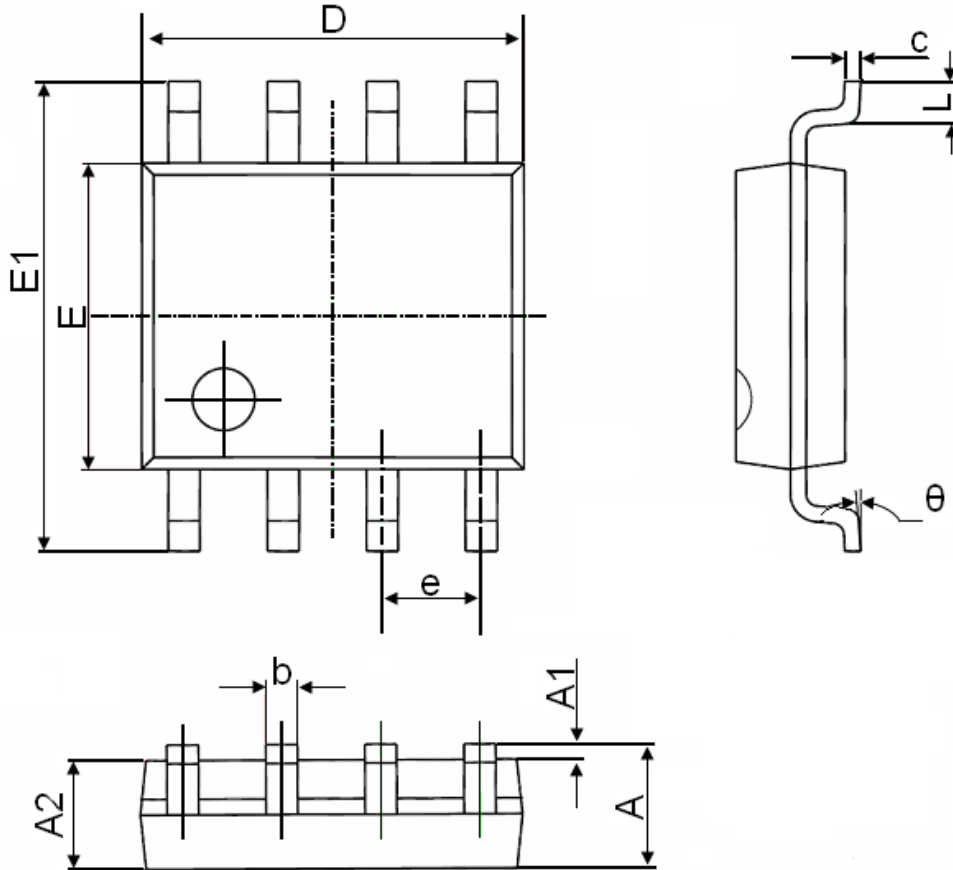


Figure 10. Normalized Thermal Transient Impedance Curve

SOP-8 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°